

Search Notes

Application/Control No.

10/522,432

Examiner

Jean F. Duverne

Applicant(s)/Patent under
Reexamination

MATTHIES ET AL.

Art Unit

2839

SEARCHED

Class	Subclass	Date	Examiner
439	62	2/1/2006	JFD
	260		
	637		
	188		
	83		
	61		
	67	2/1/2006	JFD

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner